# DYNAMIC VOLTAGE SCALING ALGORITHMS FOR POWER CONSTRAINED MOTION ESTIMATION

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### ABSTRACT

In this paper, we apply dynamic voltage scaling (DVS) to the matching metric computation (MMC) used within motion estimation (ME) in typical video encoders. Our approach is based on "soft DSP" concepts. We analyze the effect of ME errors (due to DVS) in overall coding performance. We propose a model for the resulting rate increase (at a given fixed quantization parameter) as a function of input characteristics and input voltage, for given ME algorithm and MMC architecture. This model is validated using simulations. We then compare ME algorithms and MMC architectures, and propose a method for power saving of the ME process that depend on input characteristics and desired coding performance. As an illustration of the potential benefits of allowing computation errors, we show that allowing errors that lead to a small rate increase (about 3%) produces 37% power savings in the ME process, as compared to not using DVS. An essentially "error-free" DVS approach (no rate penalty) can achieve around 10% power savings.

*Index Terms*— Dynamic voltage scaling (DVS), error tolerance (ET), Soft DSP, matching metric Computation (MMC)

# 1. INTRODUCTION

Power (or energy) is the most important design constraint in many VLSI design scenarios [11]. Many approaches have been proposed for power constrained VLSI, ranging from circuit level to architectural and algorithmic level [7, 9]. Dynamic voltage scaling (DVS) is an attractive technique to reduce power consumption, as lowering input voltage by a factor J, reduces energy dissipation by almost a factor  $J^2$  [9]. Soft DSP is an efficient approach for DVS [9] that has been applied to low level systems, such as adders and multiplier-accumulators (MACs) often used in signal processing applications (e.g., linear filters and multi-input-multi-output, MIMO, systems). In soft DSP systems the input voltage is below critical voltage (i.e., we have voltage over scaling, VOS), which leads to input-dependent soft errors. Then, soft-error tolerance is achieved by using explicit error control blocks that provide error concealment so as to operate with negligible loss in algorithm performance.

In our previous work, we have shown that image/video compression systems exhibit error tolerance (ET) characteristics, *even if no explicit error control block is added*, and this under both hard errors (due to deterministic faults) [6, 5] and soft errors (due to DVS) [3]. Errors due to VOS in these applications are either i) concealed by other parts of the system (e.g., quantization can conceal errors affecting a transform computation) or ii) are "acceptable" [2]. Determining what constitutes acceptable errors is obviously an applicationspecific decision; both performance criteria and acceptability thresholds are highly dependent on the application. In [5], we studied the impact of hard errors on matching metric computation (MMC) within the motion estimation (ME) process in a video compression system. In this case, we showed that both video encoder and decoder remain operational, and thus these errors can be evaluated in terms of the compression performance penalty they produce (i.e., more bits are needed to code data at a given quality level as compared to the bit-rate required by a fault-free system operating at the same QP). This performance penalty may be acceptable for specific application scenarios. We have also provided a primarily *experimental* evaluation of the behavior of several ME algorithms under "soft error" conditions applying soft DSP approaches to MMC within ME process [3].

In this paper, we extend our previous work [3] to a DVS scenario. The main novelty comes from i) a model for degradation in video coding performance due to voltage scaling, as a function of input characteristics and for given ME algorithms and MMC architectures (this model can used to select input voltage values for target coding performance criteria), and ii) using this model to compare various ME algorithms and MMC architectures in terms of their coding performance under DVS. Our proposed models for DVS performance are designed to be used in hardware-based video encoders, but could also prove useful in the context of general purpose processors for which power control is enabled (see [8] for an example). Since ME is performed at the encoder, our work is primarily applicable to scenarios where power-constrained devices (e.g., cellphones) are used for video capture and encoding.

To introduce our model, we first briefly explain the ME process, introduce different MMC architectures we will use, and describe the basic setting for analysis (Section 2). Each MMC architecture involves several "soft" adders, such as those used in the soft DSP context. We provide a detailed analysis of errors due to voltage scaling for a single adder (Section 3). Then we extend it to model errors in typical MMC architectures and the performance degradation due to soft error as a function of input voltage and input characteristics. This model is validated using simulations (Section 4). Using this model, we propose a voltage control method, which based on our simulations can achieve about 37% power savings in the ME process, as compared to not applying any voltage scaling, with very slight increase in rate (around 3%).

## 2. MOTION ESTIMATION WITH SOFT ERROR

The ME process comprises a search strategy of the motion vector (ME algorithm) and a matching metric computation (MMC). The search strategy decides a set of candidate MVs and then proceeds to compute the matching metric for the candidates and select the one that minimizes the matching metric (typically, sum of absolute differences (SAD) or sum of squared differences (SSD); in our case

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#### SAD is used).

There are several types of hardware architectures [12] to compute the matching metrics, with different levels of parallelism. We will refer to them as MMC architectures. Among those, we choose a serial and parallel architecture for analysis (see Figure 1). The serial architecture has  $M^2$  serially connected adders for SAD computation between two  $M \times M$  macroblocks. It is simple but requires longer running time compared to the parallel one. As shown in Figure 1, the parallel architecture has M parallel groups of "leaf" adders and M "central" adders (in total  $M^2 + M$  adders are needed). Each group of leaf adders consists of M adders and computes the sum of M AD values. Then, the central adders compute the final SAD adding up M partial SAD values. In leaf adders, outputs are small compared to the final SAD value (on average partial SAD values in a set of leaf adders will be smaller than  $\frac{SAD}{M}$ ). Thus errors with magnitude larger than  $\frac{SAD}{M}$  (small compared to the final SAD) are unlikely to be generated in the leaf adders, because soft errors in an adder cannot be greater than the output of the adder (see Section 2.1.2). Thus we only need to focus on the central adders in parallel MMC architecture case, as this is where the larger errors are likely to happen. These central adders can be modelled as M serial adders whose inputs are the sum of M AD values.



Fig. 1. MMC Architectures. Left: Serial Architecture, Right: Parallel Architecture

For each macroblock of size  $M \times M$  in the current frame, the MMC process computes the matching metric for each candidate block in the reference frame's search window; these are denoted  $SAD_1$ ,  $SAD_2, \ldots, SAD_N$  (sorted in magnitude of  $SAD_i$ , with  $SAD_1$  the largest one) where N is number of candidates. We define  $MV_{min}$  as the best MV, which corresponds to the index such that  $SAD_i$  is minimum (here  $MV_{min} = N$ ), and  $SAD_{min}$  as a minimum SAD among all  $SAD_i$  (here  $SAD_{min} = SAD_N$ ).

When the MMC process operates with Vdd below its normal operating range (i.e., lower than  $Vdd_{crit}$ ), the above  $SAD_i$  values may be corrupted; those possibly erroneous  $SAD_i$  values are denoted  $SAD'_1, SAD'_2, \ldots, SAD'_N$ , where  $SAD'_i = SAD_i - E_i$ , with  $E_i$  denoting the soft error due to voltage control. Denote  $MV_f$  the MV chosen when  $SAD'_i$  are used. If  $MV_f \neq MV_{min}$ , the residual block's distortion (as measured by the SAD) increases by  $E_{SAD} = SAD_{MV_f} - SAD_{min}$ . This increase in distortion ( $E_{SAD}$ ) may lead to rate increases for a given QP, which we propose to model using the quadratic (Q2) model [4]. This model has been applied in implementations of existing video encoding standards ITU-T H.264/MPEG4 AVC [1] and tends to be accurate for large data sets, such as one Group of Pictures (GOP) or one whole sequence (its accuracy increases with the number of frames being modelled). The main Q2

model is as follows:

$$R = S_1 \frac{MAD}{QP} + S_2 \frac{MAD}{QP^2},\tag{1}$$

where R is the rate, MAD is the energy of the prediction residual measured in terms of mean absolute difference (MAD), QP is the quantization parameter and  $S_1, S_2$  are parameters to be estimated. One can see that the Q2 Model can be rewritten as a linear function of SAD for a fixed QP. Now we take derivative of both terms. Then the following relation holds for a SAD increase ( $E_{SAD}$ ) and rate increase ( $\Delta R$ ):

$$\Delta R = X_1 E_{SAD} \tag{2}$$

where  $X_1$  is a parameter to be estimated for each set of frames (i.e., one GOP or whole sequence). Therefore if we know the model for  $E_{SAD}$ , we know the model for  $\Delta R$ . Now we focus on modelling  $E_{SAD}$  as a function of Vdd and input characteristics. For this purpose, in the next section we study the characteristics of soft errors in the MMC process  $(E_i)$ .

# 2.1. The MMC process with Soft Errors

An MMC system includes several n-bit adders. We assume that ripple carry adders with voltage scaling are used, as they provide useful functionality for DVS [9]. We assume that all soft adders in the MMC process have the same input voltage (Vdd), as is typically assumed in soft DSP techniques [9]. When we decrease Vdd for the adders, the circuit delay for one full adder  $(T_{FA})$  increases, but the sampling time  $(T_S)$  remains the same. Thus,  $R_S$ , the number of full adder (FA) operations possible in one  $T_S$ , will decrease. From now on, we will use  $R_S$  instead of Vdd as the parameter that controls the operating point of the system;  $R_S$  is a function of Vdd and depends on several gate parameters (see [9]). Here we will use the parameters used in [9]. If the number of FA operations required to complete one addition (i.e., the path delay divided by  $T_{FA}$ , which is obviously input dependent) is larger than  $R_S$ , then an error is generated. Our target is to model errors  $(E_i)$  due to applying  $Vdd < Vdd_{crit}$  to the MMC hardware. As a first step, we need to understand the behavior of an *n*-bit soft adder (*n*-bit ripple carry adder with voltage scaling).

2.1.1. n-bit Soft Adder



**Fig. 2.** Upper left: input with path delay equal to  $6T_{FA}$ , Lower left: output *S* with path delay equal to  $(K+1)T_{FA}$ , Right: soft error due to *Vdd* control

An *n*-bit ripple carry adder comprises *n* serially connected full adders. Denote its inputs  $A = [a_n...a_1]$  and  $B = [b_n...b_1]$ , and let  $S = A + B = [s_n...s_1]$ , with the carry denoted by  $C = [c_n...c_1]$ . Each FA has inputs  $a_i, b_i, c_{i-1}$  and outputs  $s_i, c_i$ , and each input pair  $(a_i, b_i)$  is introduced to corresponding FA simultaneously. If a carry  $c_i$  is generated in each FA, it is propagated to the next FA (see Figure 2). If  $Vdd < Vdd_{crit}$  an error can be generated if  $R_S$  is smaller than the path delay required for the computation. The total *path delay* is determined by the *longest consecutive carry propagations*. Consecutive carry propagations are generated after an initial carry generation (by an (1, 1) input pair) is followed by carry propagation inputs ((1, 0) or (0, 1) input pairs). Thus if an input has a path delay larger than  $R_S$ , carry input to the ( $R_S + k$ )-th FA is lost (k is the starting position of carry propagation) and an error with magnitude  $2^{R_S+k}$  is generated (see Figure 2).

It is interesting to note that for the path delay to be K+1 for one addition, the result, S, has to include a 1 followed by K consecutive 0s (from the (k + 1) - th bit to the (k + K) - th bit), i.e.,  $S = m2^{K+k}+R$ , where m > 0 and  $R < 2^k$ . Thus if i)  $S = m2^{K+k}+R$  where  $K \succeq R_S$ , and ii)  $a_{k+1} = 1$  (automatically  $b_{k+1} = 1$ ), then an error with magnitude  $2^{R_S+k}$  is generated. Here we can see that errors can be no greater than S and that an error cannot be generated if  $S < 2^{R_S}$ . Since  $a_{k+1}$  corresponds to a lower significance bit (as compared to S), we can assume that S and  $a_{k+1}$  are independent. And if we assume i)  $P(S = m2^{R_S+k} + R)$  is similar for all R (S has smooth distribution), and ii) that  $p(a_{k+1} = 1) = \frac{1}{2}$ , we can model the error in a soft adder as:

$$P(error = 2^{R_S+k}) = \sum_{m=1}^{T} P(S = m2^{R_S+k})2^{k-1}, \quad (3)$$

where  $T = \lceil \frac{2^n}{2^R S^{+k}} \rceil$  and *n* is the width of the adder. 2.1.2. Soft Error in the MMC process

If at least one of the intermediate soft adders satisfies the condition for error generation, an error occurs. This condition depends on  $R_S$ and on the outputs of intermediate adders, each of which is a partial SAD of the l-th node  $(PSAD_l)$ . Thus we can model the error,  $E_i$ , given  $SAD_i$ , if we know characteristics of  $PSAD_l$ . In [10], given a final SAD  $(SAD_i)$ , characteristics of l-th partial MAD  $(PMAD_l)$ are modelled as random variables with mean  $\frac{SAD_i}{M^2}$ . Since  $PSAD_l$ is a multiple of  $PMAD_l$ , a model for  $PSAD_l$  can be easily derived for a given final SAD. We can then derive a model for  $E_i$ ; this will be the probability of error for the single-adder case summed over all intermediate nodes, i.e.,

$$P(E_i = 2^{R_S + k}) = \sum_{m=1}^{T} \sum_{l}^{L} P_{PSAD_l}(PSAD_l = m2^{R_S + k})2^{k-1}$$
(4)

Here we assume that an error occurs on only one intermediate node so that  $E_i = 2^{R_S+k}$ , k = 0, 1, ... From our simulations, we observed that the probability that errors occur in more than one node tends to be negligible. We make use of this single-error assumption as it simplifies the modelling and the experimental results validate it.

Any given  $SAD_i$  value can be produced by many different combinations of intermediate node outputs  $(PSAD_l)$ . Thus, since  $E_i$ depends on those intermediate computations, different  $E_i$  can be generated for a given  $SAD_i$  value. We model  $E_i$  as a random variable which is independent of  $SAD_i$  if  $SAD_i \ge 2^{R_S}$  (if  $SAD_i < 2^{R_S}$  then  $E_i = 0$ ), but cannot take arbitrary values. In particular we will have that  $E_i \le SAD_i$ ; our simulation shows that correlation between  $SAD_i$  and  $E_i$  is very small (< 0.03).

### 3. CODING PERFORMANCE MODELS

With our proposed model for  $E_i$  we can now derive an analytical model for  $E_{SAD}$  (the expected value of the increase in prediction residual SAD) as a function of  $SAD_i$  and  $R_S$ . For each  $SAD_i$ there is a possibility that due to an error, *i* will be chosen as the MV  $(P(i = MV_f))$ , instead of the correct vector. When this happens the SAD of the prediction residual increases by  $SAD_i - SAD_{min}$ . But only  $SAD_i \ge 2^{R_S}$  can result in a error and thus lead to an erroneous MV choice. Thus we define Q as the set of  $SAD_i$  for which errors can occur so that i is selected as  $MV_f$  ( $Q = \{i | 2^{R_S} \le SAD_i\}, N_Q = |Q|$ ). Then  $E_{SAD}$  can be written as follows:

$$E_{SAD} = \sum_{i \in Q} (SAD_i - SAD_{min})P(i = MV_f), \qquad (5)$$

To estimate  $E_{SAD}$  according to (5), we evaluate  $P(i = MV_f)$  first. For  $i = MV_f$ ,  $SAD'_i$  needs to be smaller than all other  $SAD'_w$ , which can be stated as follows:

$$P(i = MV_f) = \prod_{w \neq i} P(SAD'_w > SAD'_i)$$
(6)

This equation is based on the observation that each error  $(E_w)$  is almost independent of corresponding SAD value  $(SAD_w)$  (see Section 2.1.2). For *i* to be chosen as the  $MV_f$ ,  $SAD'_i$  should be the minimum among all  $SAD'_w$ , so that  $SAD'_i < SAD_{min}$  and thus the following holds:

$$P(i = MV_f) = \int_0^{SAD_{min}} P(SAD'_i = x) \prod_{w \neq i} P(SAD'_w > x) dx$$
(7)

Here we can derive a simple expression of  $P(SAD'_w < x)$ which is a linear function of x, assuming that  $\sum_{l}^{L} P_{PSAD_{l}}(PSAD_{l} = m2^{R_{S}+k})$  (probability that the value of one of the intermediate outputs  $(PSAD_{l})$  is  $m2^{R_{S}+k}$ ) is independent of k and takes a constant value  $p_{0}$ .

$$P(SAD'_w < x) \approx \frac{x}{2^{R_S+1}} p_0 \tag{8}$$

Thus applying (8) to (7), we obtain:

$$P(i = MV_f) \approx \frac{1}{N_Q} (1 - (1 - \gamma \frac{SAD_{min}}{2^{R_S}})^{N_Q}), \gamma = \frac{p_0}{2} \quad (9)$$

Generally  $p_0$  will depend on the MMC architecture. In a serial architecture there are  $M^2$  intermediate nodes to consider, while we only need to consider M nodes in a parallel architecture (the central nodes, as discussed in Section 2.1.2). If the number of intermediate nodes is larger for the same final SAD, there are more chances for one of the intermediate nodes to be  $m2^{R_S+k}$ . Thus  $p_0$  corresponding to a serial MMC architecture is larger than for a parallel one. These  $p_0$  values can be precalculated for given  $SAD_w$ ,  $R_S$ , and MMC architectures. Now we apply (9) to (5) to get the following expression for  $E_{SAD}$ :

$$E_{SAD} \approx \left(\overline{SAD_Q} - SAD_{min}\right) \left(1 - \left(1 - \gamma \frac{SAD_{min}}{2^{R_S}}\right)^{N_Q}\right)$$
(10)

where  $\overline{SAD_Q}$  is a mean SAD value over set Q, and  $\Delta R = X_1 E_{SAD}$ .

#### 4. SIMULATION AND DISCUSSION

To evaluate our proposed model, the Foreman and Stefan sequences were tested. We simulated the effect of a series of  $R_S$  values using an H.264/AVC baseline profile encoder with full search/EPZS ME algorithms and serial/parallel MMC architectures. Only  $16 \times 16$  block partitions and a single reference were considered for ME; QP was fixed and rate distortion optimization was turned on. We assign 15 frames to each group of pictures (GOP), and use an IPPP GOP structure. We collect real rate increase ( $\Delta R$ ) data by encoding each GOP with/without errors (for  $R_S = 5, 7, ...15$  and  $Vdd_{crit}$  corresponding to  $R_S = 16$ ). We estimate  $\Delta R$  with  $E_{SAD}$  computation and  $X_1$ estimation for each GOP;  $E_{SAD}$  is computed by collecting  $SAD_i$ statistics during the normal encoding operation without errors, and  $X_1$  is estimated by evaluating the ratio of real  $\Delta R$  and computed  $E_{SAD}$  for one specific  $R_S$  point with nonzero  $E_{SAD}$  ( $R_S^L$ ). Figure 3 shows the variations of  $\Delta R$  as a function of Vdd, which will be useful to design a power control mechanism. This result shows that we can precisely estimate  $\Delta R$  with our analytical model in the  $R_S$  range of interest.

Using simulation result and model, we can compare MMC architectures and ME algorithms. The slope of  $\Delta R$  for serial MMC architecture is larger than one of a parallel architecture, because  $p_0$  of a serial MMC architecture is larger (see Section 3). But the saturated  $\Delta R$  value is similar because it only depends on  $SAD_{min}, \overline{SAD_Q},$ which is the same for both cases. Since a EPZS search strategy uses a good prediction algorithm to select a small number of MV candidates, which are already near the minimum SAD point, EPZS has smaller  $N_Q, SA\overline{D_Q}$  than the full search algorithm. Thus  $\Delta R$  of EPZS is always smaller than that for the full search case. In summary, EPZS search algorithm and parallel MMC architecture are better than full search algorithm and serial MMC architecture respectively. Note that we do not consider the inherent difference in complexity, regularity, and memory usage between EPZS and FS algorithm; FS algorithm has more searching points but has more regular structure and memory usage than EPZS.

If we can estimate  $\Delta R$  as a function of  $R_S$  for a given sequence before encoding, we can control Vdd in a optimal fashion during the encoding process, thus saving power. A normal video encoder optimization scheme only considers rate and distortion. But in encoding scenarios that require small power consumption, e.g., hand held devices, we need to take power consumption into consideration by adding this to the cost function. To estimate  $\Delta R$  data, we need information about  $SAD_i$  (SAD value for each MV candidate in one macroblock). Since information about  $SAD_i$  is not available before encoding, it can be estimated, for example, by encoding without DVS a single frame within a GOP. This approach will be effective if  $E_{SAD}$  and  $X_1$  do not change much in within one GOP. Selecting an optimal Vdd point can be done using various optimization techniques, such as those based on lagrange multipliers. A heuristic method would be to choose a threshold for rate change  $(\Delta R_{th})$ , and select Vdd such that estimated  $\Delta R$  is less than  $\Delta R_{th}$ . Using these algorithms, we can change Vdd dynamically depending on input characteristic with a slight additional complexity in the encoding system, but with potentially large power savings. Figure 4 highlights the potential for savings in the ME process using DVS; setting  $\Delta R_{th} = 0.1$ , leads to 37% power reduction when using EPZS and the parallel MMC architecture. Considering that a significant percentage of power consumption is due to the ME process (at least 20% in case of MPEG2 encoder), total power savings within the video encoding system can be significant.

### 5. REFERENCES

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**Fig. 3**. Rate change due to DVS in ratio compared to original rate (dot: estimated data using our model, solid: real data); using a FOREMAN sequence, QP=20



Fig. 4. Power saving effect of ME process using DVS for various ME algorithms and MMC architectures; considering redundancy due to encoding one frame of every GOP with  $Vdd_{crit}$  and  $R_S^L$  for  $SAD_i$  information and  $X_1$  estimation, FOREMAN sequence, QP=20, gate parameters ( $\alpha = 2.0, Vdd_{crit} = 3.3V, V_t = 0.62V$ )